

**July 2008** 

### FDB024N06

# N-Channel PowerTrench<sup>®</sup> MOSFET 60V, 265A, 2.4m $\Omega$

#### **Features**

- $R_{DS(on)} = 1.8 m\Omega$  ( Typ.) @  $V_{GS} = 10 V$ ,  $I_D = 75 A$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R<sub>DS(on)</sub>
- · High power and current handling capability
- · RoHS compliant



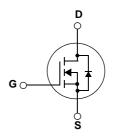
### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

### **Application**

• DC to DC convertors / Synchronous Rectification





### MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		Ratings	Units
V <sub>DSS</sub>	Drain to Source Voltage			60	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
	Drain Current	Continuous (T <sub>C</sub> = 25°C, Sili	con Limited)	265*	Α
I <sub>D</sub>		con Limited)	190*	Α	
		- Continuous (T <sub>C</sub> = 25°C, Pa	ckage Limited)	120	Α
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	1060	Α
E <sub>AS</sub>	Single Pulsed Avalanche	Pulsed Avalanche Energy (Note 2)		2531	mJ
dv/dt	Peak Diode Recovery dv/	dt	(Note 3)	3.5	V/ns
n	Dawer Dissipation	(T <sub>C</sub> = 25°C)		395	W
$P_{D}$	Power Dissipation - Derate above 25°C			2.6	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Te	emperature Range		-55 to +175	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

<sup>\*</sup>Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

### **Thermal Characteristics**

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.38	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	*C/VV

## Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB024N06	FDB024N06	D2-PAK	330mm	24mm	800

### **Electrical Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_C = 25^{\circ} C$	60	-	-	V
ΔBV <sub>DSS</sub> ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.04	-	V/°C
Jara Cata Valtaga Prain C	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	μА
DSS Zero Gate Voltage Drain Current		$V_{DS} = 60V, V_{GS} = 0V, T_{C} = 150^{\circ}C$	-	-	500	μА
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$		2.5	3.5	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$		1	1.8	2.4	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_D = 75A$ (N	Note 4)	-	200	=	S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		11190	14885	pF
C <sub>oss</sub>	Output Capacitance			1610	2140	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	-	750	1125	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	174	226	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 48V, I_{D} = 75A$	-	54	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V (Note 4, 5)	-	50	-	nC

### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	134	278	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 30V, I_{D} = 75A$	-	324	658	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 25\Omega$	-	348	706	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note		250	510	ns

### **Drain-Source Diode Characteristics**

Is	Maximum Continuous Drain to Source Diode Forward Current			-	-	265	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	-	1060	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 75A		-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 75A		-	69	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge $dI_F/dt = 100A/\mu s$ (Note 4)		ie 4)	-	152	-	nC

- Notes: 1: Repetitive Rating: Pulse width limited by maximum junction temperature 2: L = 0.9mH,  $I_{AS} = 75A$ ,  $V_{DD} = 50V$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^{\circ}C$  3:  $I_{SD} \le 75A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$  4: Pulse Test: Pulse width  $\le 300\mu s$ , Duty Cycle  $\le 2\%$  5: Essentially Independent of Operating Temperature Typical Characteristics

### **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

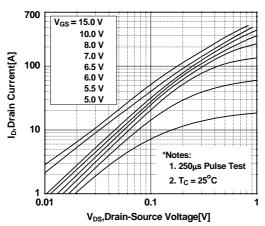


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

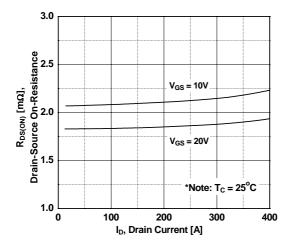


Figure 5. Capacitance Characteristics

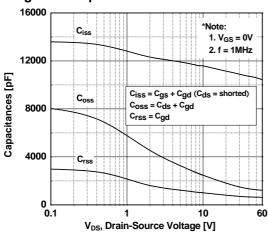


Figure 2. Transfer Characteristics

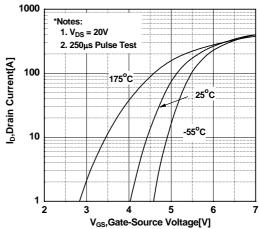


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

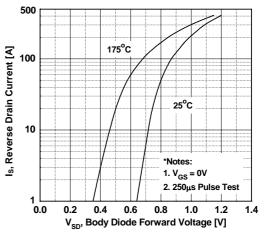
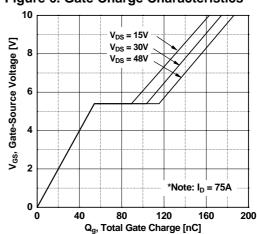


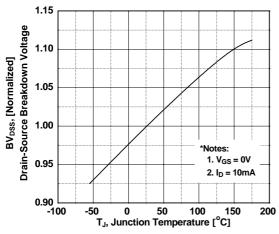
Figure 6. Gate Charge Characteristics



FDB024N06 Rev. A3 www.fairchildsemi.com

### **Typical Performance Characteristics (Continued)**

Figure 7. Breakdown Voltage Variation vs. Temperature



vs. Temperature 2.0

Figure 8. On-Resistance Variation

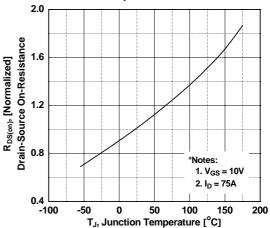
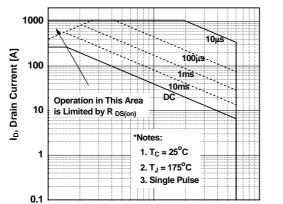


Figure 9. Maximum Safe Operating Area



10

V<sub>DS</sub>, Drain-Source Voltage [V]

Figure 10. Maximum Drain Current vs. Case Temperature

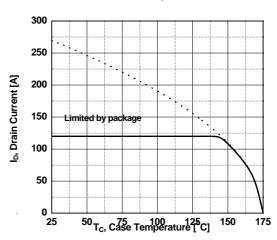
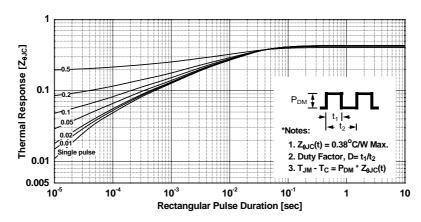


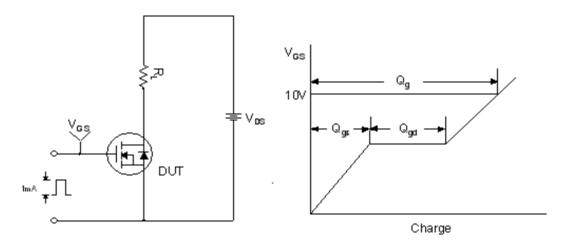
Figure 11. Transient Thermal Response Curve



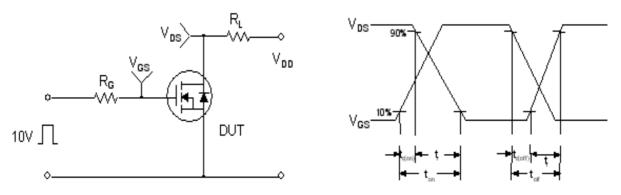
100

FDB024N06 Rev. A3 www.fairchildsemi.com

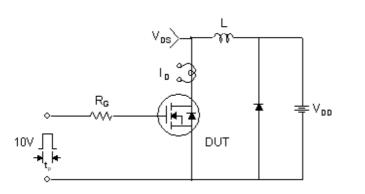
### **Gate Charge Test Circuit & Waveform**

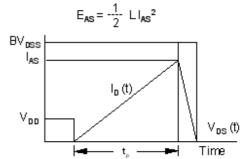


### **Resistive Switching Test Circuit & Waveforms**

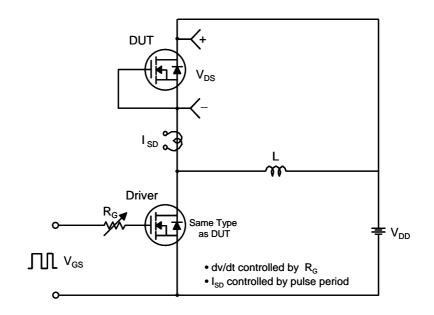


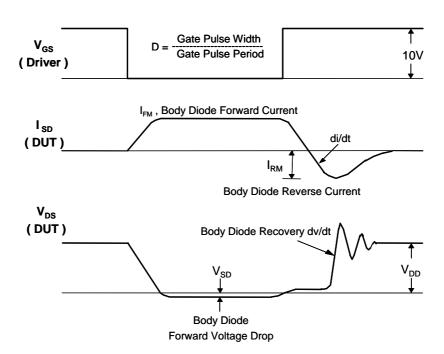
**Unclamped Inductive Switching Test Circuit & Waveforms** 





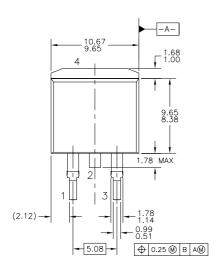
### Peak Diode Recovery dv/dt Test Circuit & Waveforms

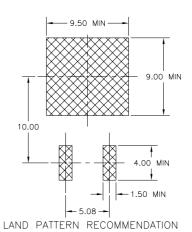


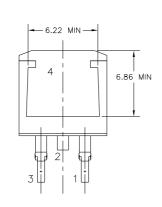


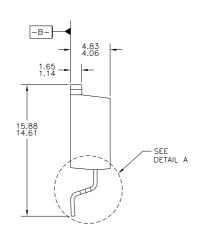
### **Mechanical Dimensions**

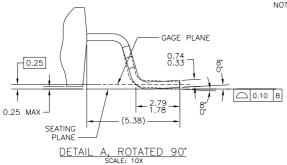
# D2-PAK











- NOTES: UNLESS OTHERWISE SPECIFIED

  A) ALL DIMENSIONS ARE IN MILLIMETERS.

  B) REFERENCE JEDEC, TO-263, ISSUE D, VARIATION AB, DATED JULY 2003.

  C) DIMENSIONING AND TOLERANCING PER ANSI Y14.5M 1982.

  D) LOCATION OF THE PIN HOLE MAY VARY (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF THE PACKAGE).

  B

  E) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

TO263A02REVD

Dimensions in Millimeters





#### **TRADEMARKS**

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidianries, and is not intended to be an exhaustive list of all such trademarks.

Build it Now™ CorePLUS™ CorePOWER™

 $CROSSVOLT^{\text{TM}}$ CTL™

Current Transfer Logic™ EcoSPARK®

EfficentMax™ EZSWITCH™ \*

Fairchild® Fairchild Semiconductor®

FACT Quiet Series™ **FACT** FAST®

FastvCore™ FlashWriter® \* **FPS™** F-PFS™ FRFFT®

Global Power Resource<sup>SM</sup>

Green FPS™ Green FPS™ e-Series™

GTO™ IntelliMAX™ ISOPLANAR™ MegaBuck™

MICROCOUPLER™ MicroFFT™ MicroPak™ MillerDrive™

MotionMax™ Motion-SPM™ OPTOLOGIC® OPTOPLANAR® PDP SPM™ Power-SPM™ PowerTrench®

Programmable Active Droop™

QFET® QS™ Quiet Series™

RapidConfigure™ Saving our world, 1mW at a time™

SmartMax™ SMART START™

SPM®

STEALTH™ SuperFET™ SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS™ SyncFET™

SYSTEM ®

The Power Franchise®

p wer franchise TinyBoost™ TinyBuck™ TinyLogic<sup>®</sup> TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™

UHC® Ultra FRFET™ UniFFT™ VCX™

VisualMax™

\* EZSWITCH™ and FlashWriter® are trademarks of System General Corporation, used under license by Fairchild Semiconductor.

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **ANTI-COUNTERFEITING POLICY**

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Farichild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Farichild strongly encourages customers to purchase Farichild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Farichild is committed to committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors

#### PRODUCT STATUS DEFINITIONS **Definition of Terms**

		B. 6. W				
Datasheet Identification	Product Status	Definition				
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.				
Preliminary First Production		Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.				
No Identification Needed Full Production		Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.				
Obsolete Not In Production		Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.				